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July 2015

FDMS86300DC

N-Channel Dual CoolTM 56 PowerTrench[®] MOSFET

80 V, 110 A, 3.1 m Ω

Features

- Dual CoolTM Top Side Cooling PQFN package
- Max $r_{DS(on)} = 3.1 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 24 \text{ A}$
- Max $r_{DS(on)}$ = 4.0 m Ω at V_{GS} = 8 V, I_D = 21 A
- High performance technology for extremely low r_{DS(on)}
- 100% UIL Tested
- RoHS Compliant

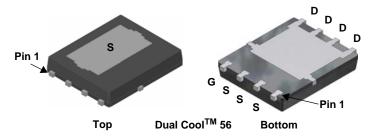


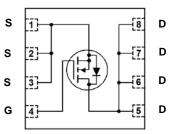
General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench® process. Advancements in both silicon and Dual Cool^{TM} package technologies have been combined to offer the lowest $r_{\text{DS(on)}}$ while maintaining excellent switching performance by extremely low Junction-to-Ambient thermal resistance.

Applications

- Synchronous Rectifier for DC/DC Converters
- Telecom Secondary Side Rectification
- High End Server/Workstation Vcore Low Side





MOSFET Maximum Ratings $T_A = 25$ °C unless otherwise noted

Symbol	Param	eter		Ratings	Units
V_{DS}	Drain to Source Voltage			80	V
V _{GS}	Gate to Source Voltage			±20	V
	Drain Current -Continuous	T _C = 25 °C		110	
I _D	-Continuous	T _A = 25 °C	(Note 1a)	24	Α
	-Pulsed		(Note 2)	260	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	240	mJ
D	Power Dissipation	T _C = 25 °C		125	W
P_{D}	Power Dissipation	T _A = 25 °C	(Note 1a)	3.2	VV
T _J , T _{STG}	Operating and Storage Junction Tempera	ature Range		-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Top Source)	2.3	
$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Bottom Drain)	1.0	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	38	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	81	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1i)	16	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1j)	23	
Rela	Thermal Resistance, Junction to Ambient	(Note 1k)	11	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
86300	FDMS86300DC	Dual Cool TM 56	13"	12 mm	3000 units

Electrical Characteristics $T_J = 25$ °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	80			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C		45		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 64 V, V _{GS} = 0 V			1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	2.5	3.3	4.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25 °C		-11		mV/°C
		$V_{GS} = 10 \text{ V}, I_D = 24 \text{ A}$		2.6	3.1	
Static Drain to Source On Res	Static Drain to Source On Resistance	V _{GS} = 8 V, I _D = 21 A		3.1	4.0	mΩ
		$V_{GS} = 10 \text{ V}, I_D = 24 \text{ A}, T_J = 125 °C$		4.1	5.0	
g _{FS}	Forward Transconductance	$V_{DD} = 10 \text{ V}, I_{D} = 24 \text{ A}$		79		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 40 V V 0 V		5265	7005	pF
C _{oss}	Output Capacitance	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1 \text{ MHz}$		929	1235	pF
C _{rss}	Reverse Transfer Capacitance	1 – 1 1011 12		21	50	pF
R_g	Gate Resistance		0.1	1.2	2.6	Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time				29	47	ns
t _r	Rise Time	V _{DD} = 40 V , I _D = 24	$V_{DD} = 40 \text{ V}, I_{D} = 24 \text{ A},$ $V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$		25	44	ns
t _{d(off)}	Turn-Off Delay Time	V _{GS} = 10 V, R _{GEN} =			35	57	ns
t _f	Fall Time				9	18	ns
0	Total Gate Charge	$V_{GS} = 0 \text{ V to } 10 \text{ V}$			72	101	nC
$Q_{g(TOT)}$	Total Gate Charge	$V_{GS} = 0 \text{ V to 8 V}$	V _{DD} = 40 V		59	84	nC
Q_{gs}	Total Gate Charge		_D = 24 A		26		nC
Q_{gd}	Gate to Drain "Miller" Charge				14		nC

Drain-Source Diode Characteristics

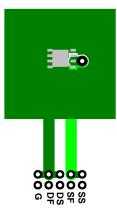
V _{SD} S	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 2.7 \text{ A}$ (Note 2)	0.72	1.2	\/
		$V_{GS} = 0 \text{ V}, I_S = 24 \text{ A}$ (Note 2)	0.80	1.3	V
I _S	Diode continuous forward current	T _C = 25 °C		75	Α
I _{S, pulse}	Diode pulse current	1C = 25 C		150	A
t _{rr}	Reverse Recovery Time	I _F = 24 A, di/dt = 100 A/μs	56	88	ns
Q _{rr}	Reverse Recovery Charge	- 1 _F = 24 A, α/αι = 100 A/μs	42	67	nC

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Top Source)	2.3	
$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Bottom Drain)	1.0	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	38	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	81	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1c)	27	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1d)	34	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1e)	16	00.00
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1f)	19	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1g)	26	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1h)	61	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1i)	16	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1j)	23	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1k)	11	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1I)	13	

NOTES

1. R_{0,1A} is determined with the device mounted on a FR-4 board using a specified pad of 2 oz copper as shown below. R_{0,1C} is guaranteed by design while R_{0,1C} is determined by the user's board design.



a. 38 °C/W when mounted on a 1 in² pad of 2 oz copper



b. 81 °C/W when mounted on a minimum pad of 2 oz copper

- c. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in² pad of 2 oz copper
- d. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper
- e. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in² pad of 2 oz copper
- f. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper
- g. 200FPM Airflow, No Heat Sink,1 in² pad of 2 oz copper
- h. 200FPM Airflow, No Heat Sink, minimum pad of 2 oz copper
- i. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in 2 pad of 2 oz copper
- j. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper
- k. 200FPM Airflow, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in² pad of 2 oz copper
- $I.\ 200 FPM\ Airflow,\ 45.2x41.4x11.7mm\ Aavid\ Thermalloy\ Part\ \#\ 10-L41B-11\ Heat\ Sink,\ minimum\ pad\ of\ 2\ oz\ copper$
- 2. Pulse Test: Pulse Width < 300 $\mu\text{s},$ Duty cycle < 2.0%.
- 3. Starting T $_{J}$ = 25 $^{o}C,\,L$ = 0.3 mH, I $_{AS}$ = 40 A, V $_{DD}$ = 72 V, V $_{GS}$ = 10 V.

Typical Characteristics $T_J = 25$ °C unless otherwise noted

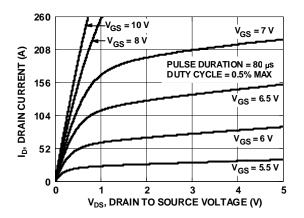


Figure 1. On-Region Characteristics

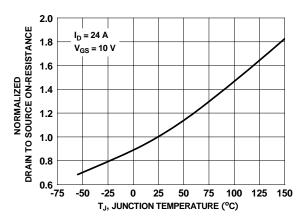


Figure 3. Normalized On-Resistance vs Junction Temperature

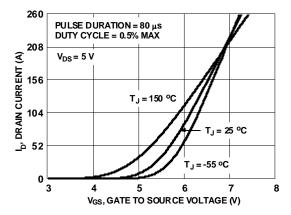


Figure 5. Transfer Characteristics

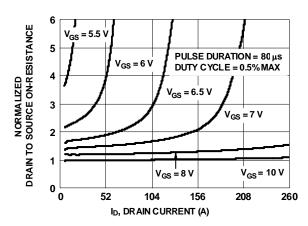


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

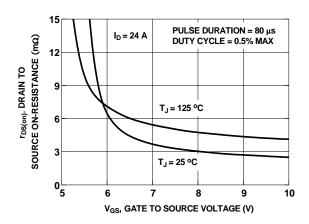


Figure 4. On-Resistance vs Gate to Source Voltage

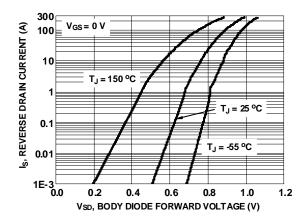


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted

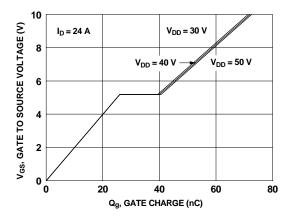


Figure 7. Gate Charge Characteristics

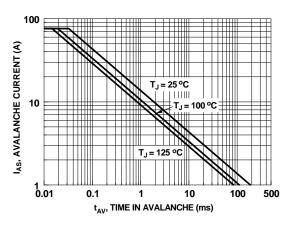


Figure 9. Unclamped Inductive Switching Capability

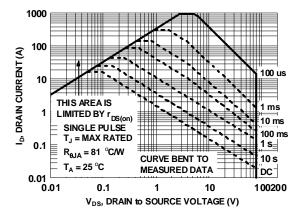


Figure 11. Forward Bias Safe Operating Area

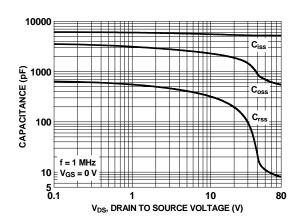


Figure 8. Capacitance vs Drain to Source Voltage

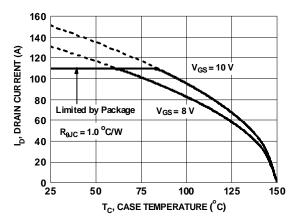


Figure 10. Maximum Continuous Drain Current vs Case Temperature

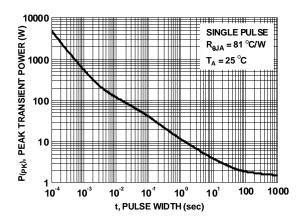


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics $T_J = 25$ °C unless otherwise noted

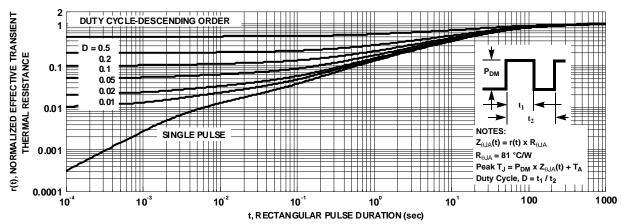
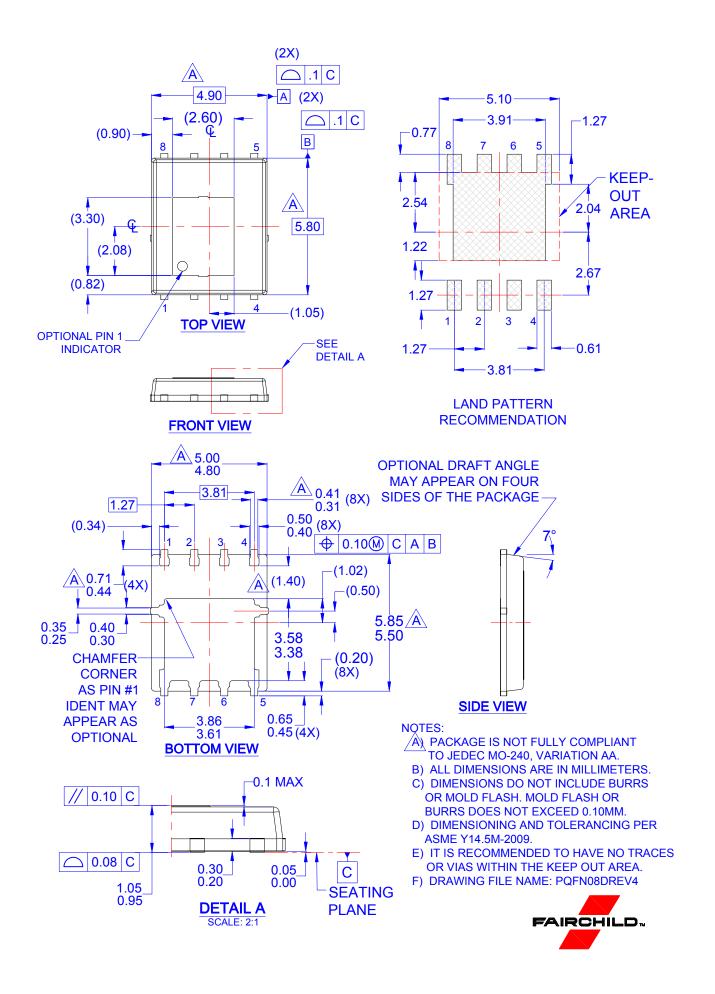


Figure 13. Junction-to-Ambient Transient Thermal Response Curve



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